ON Semiconductor

Is Now



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Power MOSFET

25 V, 49 A, Single N-Channel, DPAK/IPAK

Features

- Trench Technology
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- These are Pb-Free Devices

Applications

- VCORE Applications
- DC-DC Converters
- High Side Switching

MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

Para	Symbol	Value	Unit		
Drain-to-Source Vo	Drain-to-Source Voltage				
Gate-to-Source Vol	V_{GS}	±20	V		
Continuous Drain Current R _{θJA}		T _A = 25°C	I _D	11.3	Α
(Note 1)		T _A = 85°C		8.8	
Power Dissipation R _{θJA} (Note 1)		T _A = 25°C	P _D	1.95	W
Continuous Drain Current R _{BJA}	1	T _A = 25°C	ID	9.2	Α
(Note 2)	Steady State	T _A = 85°C		7.1	
Power Dissipation $R_{\theta JA}$ (Note 2)	State	T _A = 25°C	P _D	1.27	W
Continuous Drain Current R _{BJC}		$T_C = 25^{\circ}C$	I _D	49	Α
(Note 1)		T _C = 85°C		38	
Power Dissipation R _{θJC} (Note 1)		T _C = 25°C	P _D	36.6	W
Pulsed Drain Current	t _p =10μs	T _A = 25°C	I _{DM}	98	Α
Current Limited by P	ackage	T _A = 25°C	I _{DmaxPkg}	35	Α
Operating Junction a Temperature	Operating Junction and Storage Temperature				°C
Source Current (Boo	I _S	30.5	Α		
Drain to Source dV/d	dV/dt	6	V/ns		
Single Pulse Drain–to–Source Avalanche Energy ($T_J = 25^{\circ}C$, $V_{DD} = 50$ V, $V_{GS} = 10$ V, $I_L = 11$ A_{pk} , $L = 1.0$ mH, $R_G = 25$ Ω)			EAS	60.5	mJ
Lead Temperature for (1/8" from case for 1		Purposes	TL	260	°C

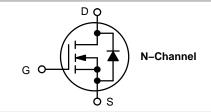
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.



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V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
25 V	9.3 mΩ @ 10 V	49 A
20 1	14 mΩ @ 4.5 V	49 A







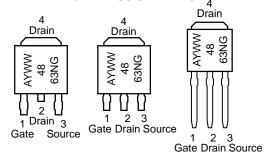


DPAK
CASE 369AA
(Bent Lead)
STYLE 2

3 IPAK CASE 369AC (Straight Lead)

IPAK
CASE 369D
(Straight Lead
DPAK) STYLE 2

MARKING DIAGRAMS & PIN ASSIGNMENTS



A = Assembly Location*

Y = Year

WW = Work Week

4863N = Device Code

G = Pb-Free Package

* The Assembly Location code (A) is front side optional. In cases where the Assembly Location is stamped in the package, the front side assembly code may be blank.

ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 6 of this data sheet.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{ heta JC}$	4.1	°C/W
Junction-to-TAB (Drain)	$R_{\theta JC-TAB}$	3.5	
Junction-to-Ambient - Steady State (Note 1)	$R_{\theta JA}$	77	
Junction-to-Ambient - Steady State (Note 2)	$R_{ heta JA}$	118	

- 1. Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
- 2. Surface-mounted on FR4 board using the minimum recommended pad size.

FI FCTRICAL CHARACTERISTICS (T₁ = 25°C unless otherwise specified)

Parameter	Symbol	Test Cond	lition	Min	Тур	Max	Unit
OFF CHARACTERISTICS	•						•
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		25			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /				23		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	$V_{GS} = 0 V$	T _J = 25°C			1.0	μΑ
		$V_{DS} = 20 \text{ V}$	T _J = 125°C			10	
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS}$	_S = ±20 V			±100	nA
ON CHARACTERISTICS (Note 3)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_{D}$	= 250 μΑ	1.45		2.5	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				5.0		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 30 A		8.4	9.3	mΩ
		V _{GS} = 4.5 V	I _D = 30 A		12.8	14	1
Forward Transconductance	9 _{FS}	V _{DS} = 1.5 V, I _D = 15 A					S
CHARGES AND CAPACITANCES							
Input Capacitance	C _{ISS}	$V_{GS} = 0 \text{ V}, f = 1.0 \text{ MHz}, V_{DS} = 12 \text{ V}$			990		pF
Output Capacitance	Coss				253		
Reverse Transfer Capacitance	C _{RSS}				144		
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 4.5 V, V _{DS} =	15 V, I _D = 30 A		9.0	13.5	nC
Threshold Gate Charge	Q _{G(TH)}				1.0		
Gate-to-Source Charge	Q _{GS}				3.4		
Gate-to-Drain Charge	Q_{GD}				4.1		
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} = 15 V, I _D = 30 A			17.8		nC
SWITCHING CHARACTERISTICS (Note	4)						
Turn-On Delay Time	t _{d(ON)}	$V_{GS} = 4.5 \text{ V}, V_{DS} = 15 \text{ V},$			11.5		ns
Rise Time	t _r	$I_D = 15 A, R_G$	$=3.0 \Omega$		19.7		1
Turn-Off Delay Time	t _{d(OFF)}				13.5		1
Fall Time	t _f				3.6		1

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 3. Pulse Test: pulse width \leq 300 μ s, duty cycle \leq 2%.

- 4. Switching characteristics are independent of operating junction temperatures.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified) (continued)

Parameter	Symbol	Test Con	dition	Min	Тур	Max	Unit
SWITCHING CHARACTERISTICS (N	lote 4)						
Turn-On Delay Time	t _{d(ON)}	$V_{GS} = 11.5 \text{ V}, V_{DS} = 15 \text{ V},$ $I_{D} = 15 \text{ A}, R_{G} = 3.0 \Omega$			7.0		ns
Rise Time	t _r				16.5		
Turn-Off Delay Time	t _{d(OFF)}				20.2		
Fall Time	t _f				2.0		
DRAIN-SOURCE DIODE CHARACT	ERISTICS						
Forward Diode Voltage	V_{SD}	V _{GS} = 0 V,	T _J = 25°C		0.96	1.2	V
		$I_S = 30 \text{ A}$ $T_J = 125^{\circ}\text{C}$		0.83			
Reverse Recovery Time	t _{RR}	$V_{GS} = 0 \text{ V, dIS/dt} = 100 \text{ A/}\mu\text{s,}$ $I_{S} = 30 \text{ A}$			10.9		ns
Charge Time	t _a				5.4		
Discharge Time	t _b				5.5		
Reverse Recovery Charge	Q_{RR}				2.7		nC
PACKAGE PARASITIC VALUES							
Source Inductance	L _S	$T_A = 25$	5°C		2.49		nΗ
Drain Inductance, DPAK	L _D				0.0164		
Drain Inductance, IPAK	L _D				1.88		
Gate Inductance	L _G				3.46		
Gate Resistance	R_{G}				0.5		Ω

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

3. Pulse Test: pulse width $\leq 300~\mu s$, duty cycle $\leq 2\%$.

4. Switching characteristics are independent of operating junction temperatures.

TYPICAL PERFORMANCE CURVES

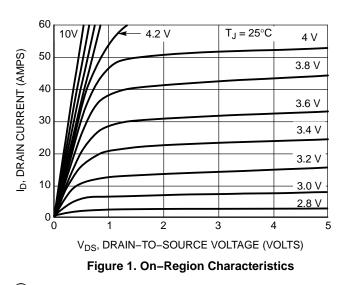
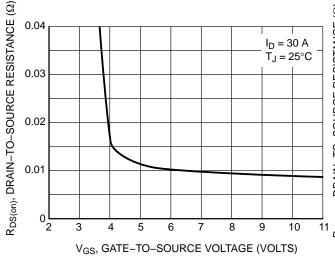


Figure 2. Transfer Characteristics



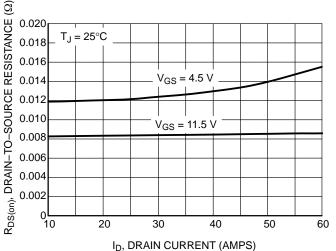
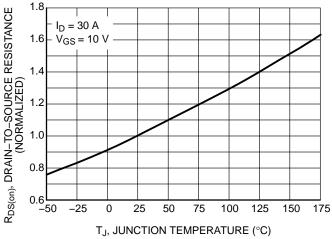


Figure 3. On-Resistance vs. Gate-to-Source Voltage

Figure 4. On–Resistance vs. Drain Current and Gate Voltage



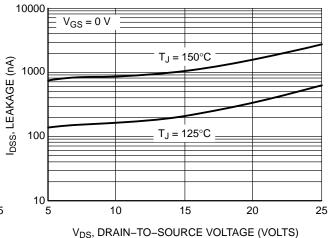


Figure 5. On–Resistance Variation with Temperature

Figure 6. Drain-to-Source Leakage Current vs. Drain Voltage

TYPICAL PERFORMANCE CURVES

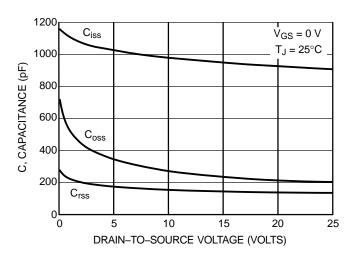


Figure 7. Capacitance Variation

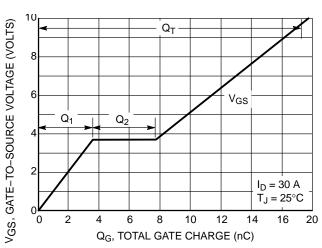


Figure 8. Gate-To-Source and Drain-To-Source Voltage vs. Total Charge

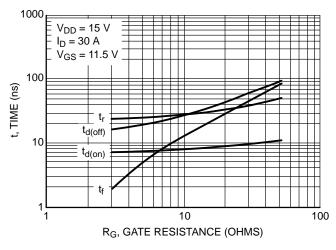


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

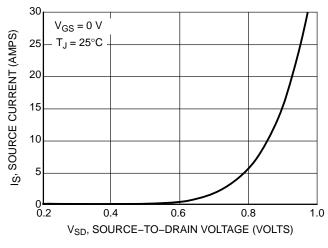


Figure 10. Diode Forward Voltage vs. Current

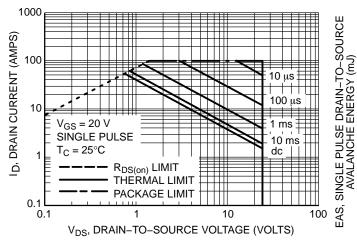


Figure 11. Maximum Rated Forward Biased Safe Operating Area

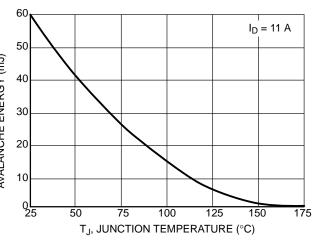


Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature

TYPICAL PERFORMANCE CURVES

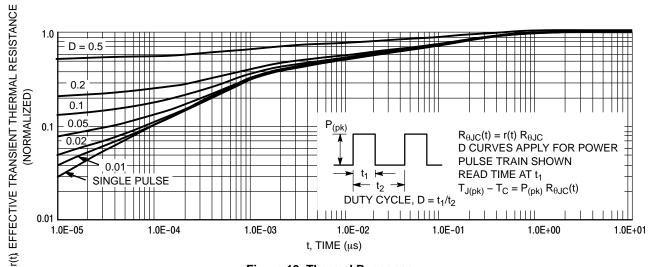


Figure 13. Thermal Response

ORDERING INFORMATION

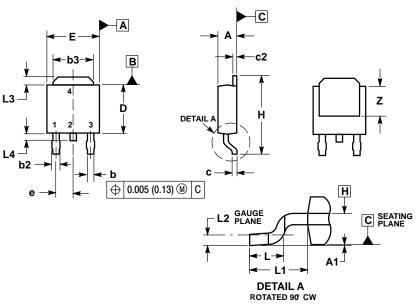
Device	Package	Shipping [†]
NTD4863NT4G	DPAK (Pb-Free)	2500 / Tape & Reel
NTD4863N-1G	IPAK (Pb-Free)	75 Units / Rail
NTD4863N-35G	IPAK Trimmed Lead (3.5 ± 0.15 mm) (Pb–Free)	75 Units / Rail

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

PACKAGE DIMENSIONS

DPAK (SINGLE GUAGE)

CASE 369AA **ISSUE B**



- NOTES:

 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.

 2. CONTROLLING DIMENSION: INCHES.

 3. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSIONS b3, L3 and Z.

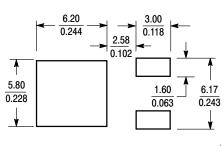
 4. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.006 INCHES PER SIDE.

 5. DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.

 6. DATUMS A AND B ARE DETERMINED AT DATUM PLANE H.

	INCHES		MILLIN	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.086	0.094	2.18	2.38
A1	0.000	0.005	0.00	0.13
b	0.025	0.035	0.63	0.89
b2	0.030	0.045	0.76	1.14
b3	0.180	0.215	4.57	5.46
С	0.018	0.024	0.46	0.61
c2	0.018	0.024	0.46	0.61
D	0.235	0.245	5.97	6.22
E	0.250	0.265	6.35	6.73
е	0.090 BSC		2.29	BSC
Н	0.370	0.410	9.40	10.41
L	0.055	0.070	1.40	1.78
L1	0.108	REF	2.74 REF	
L2	0.020	BSC	0.51 BSC	
L3	0.035	0.050	0.89	1.27
L4		0.040		1.01
Z	0.155		3.93	

SOLDERING FOOTPRINT*



 $\left(\frac{\text{mm}}{\text{inches}}\right)$ SCALE 3:1

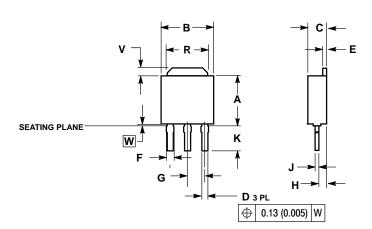
STYLE 2:

PIN 1. GATE 2. DRAIN 3. SOURCE 4. DRAIN

^{*}For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

PACKAGE DIMENSIONS

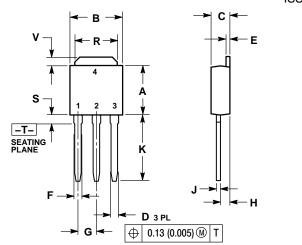
3 IPAK, STRAIGHT LEAD CASE 369AC **ISSUE O**

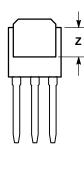


- NOTES:
 1.. DIMENSIONING AND TOLERANCING
 - PER ANSI Y14.5M, 1982. CONTROLLING DIMENSION: INCH.
- SEATING PLANE IS ON TOP OF
- DAMBAR POSITION.
 DIMENSION A DOES NOT INCLUDE
 DAMBAR POSITION OR MOLD GATE.

	INCHES		MILLIN	ETERS
DIM	MIN	MAX	MIN	MAX
Α	0.235	0.245	5.97	6.22
В	0.250	0.265	6.35	6.73
С	0.086	0.094	2.19	2.38
D	0.027	0.035	0.69	0.88
Е	0.018	0.023	0.46	0.58
F	0.037	0.043	0.94	1.09
G	0.090	BSC	2.29	BSC
Η	0.034	0.040	0.87	1.01
7	0.018	0.023	0.46	0.58
K	0.134	0.142	3.40	3.60
R	0.180	0.215	4.57	5.46
٧	0.035	0.050	0.89	1.27
W	0.000	0.010	0.000	0.25

IPAK CASE 369D ISSUE C





NOTES

- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
 2. CONTROLLING DIMENSION: INCH.

	INC	HES	MILLIN	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.235	0.245	5.97	6.35
В	0.250	0.265	6.35	6.73
С	0.086	0.094	2.19	2.38
D	0.027	0.035	0.69	0.88
E	0.018	0.023	0.46	0.58
F	0.037	0.045	0.94	1.14
G	0.090	BSC	2.29	BSC
Н	0.034	0.040	0.87	1.01
J	0.018	0.023	0.46	0.58
K	0.350	0.380	8.89	9.65
R	0.180	0.215	4.45	5.45
S	0.025	0.040	0.63	1.01
٧	0.035	0.050	0.89	1.27
Z	0.155		3.93	

STYLE 2:

PIN 1. GATE 2. DRAIN

- DRAIN
- 3. SOURCE DRAIN

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